



# **ZXTC2063E6** 40V, SOT23-6, complementary medium power transistors

# **Summary**

 $BV_{CEO} > 40 (-40)V$ 

 $BV_{ECO} > 6 (-3)V$ 

 $I_{C(cont)} = 3.5 (-3)A$ 

 $V_{CE(sat)} < 60 (-90) mV @ 1A$ 

 $R_{CE(sat)} = 38 (58) m\Omega$ 

 $P_D = 1.1W$ 



Advanced process capability has been used to achieve this high performance device. Combining NPN and PNP transistors in the SOT23-6 package provides a compact solution for the intended applications.

# C2 **E2 E1**

C1

B1

C2

Top view

### **Features**

- NPN PNP combination
- Very low saturation voltage
- High gain
- SOT23-6 package

### **Applications**

- DZSC.COM MOSFET and IGBT gate driving
- Motor drive

# Ordering information

Device	reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTC2063E6TA	7	8	3000

# **Device marking**

2063





E1

B2

E2

# Absolute maximum and thermal ratings

Parameter	Symbol	Limit	Unit
Collector-base voltage	V <sub>CBO</sub>	130(-45)	V
Collector-emitter voltage	V <sub>CEO</sub>	40(-40)	V
Emitter-collector voltage (reverse blocking)	V <sub>ECO</sub>	6(-3)	V
Emitter-base voltage	V <sub>EBO</sub>	7(-7)	V
Continuous collector current <sup>(c)(f)</sup>	I <sub>C</sub>	3.5(-3)	Α
Peak pulse current	I <sub>CM</sub>	9(-9)	Α
Base current	I <sub>B</sub>	1(-1)	Α
Power dissipation @ T <sub>amb</sub> = 25°C <sup>(a)(f)</sup>		0.7	W
Linear derating factor	$P_{D}$	5.6	mW/°C
Power dissipation @ T <sub>amb</sub> = 25°C <sup>(b)(f)</sup>		0.9	W
Linear derating factor	$P_{D}$	7.2	mW/°C
Power dissipation @ T <sub>amb</sub> = 25°C <sup>(b)(g)</sup>		1.1	W
Linear derating factor	P <sub>D</sub>	8.8	mW/°C
Power dissipation @ T <sub>amb</sub> = 25°C <sup>(c)(f)</sup>		1.1	W
Linear derating factor	P <sub>D</sub>	8.8	mW/°C
Power dissipation @ T <sub>amb</sub> = 25°C <sup>(d)(f)</sup>		1.7	W
Linear derating factor	P <sub>D</sub>	13.6	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C
Thermal resistance junction to ambient <sup>(a)(f)</sup>	$R_{\Theta JC}$	179	°C/W
Thermal resistance junction to ambient <sup>(b)(f)</sup>	$R_{\Theta JA}$	139	°C/W
Thermal resistance junction to ambient <sup>(b)(g)</sup>	$R_{\Theta JC}$	113	°C/W
Thermal resistance junction to ambient <sup>(c)(f)</sup>	$R_{ ext{ hetaJC}}$	113	°C/W
Thermal resistance junction to ambient <sup>(d)(f)</sup>	$R_{\Theta JA}$	73	°C/W

#### NOTES:

<sup>(</sup>a) For a device surface mounted on 15mm x 15mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>b) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>c) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

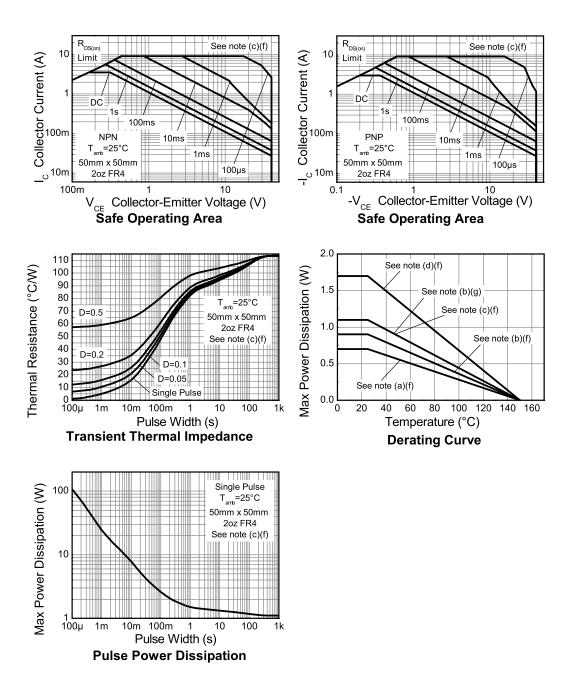
<sup>(</sup>d) As above measured at t<5 seconds.

<sup>(</sup>e) Repetitive rating - pulse width limited by maximum junction temperature. Refer to Transient Thermal Impedance graph.

<sup>(</sup>f) For device with one active die, both collectors attached to a common sink.

<sup>(</sup>g) For device with two active dice running at equal power, split sink 50% to each collector.

### Thermal characteristics



# Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated)

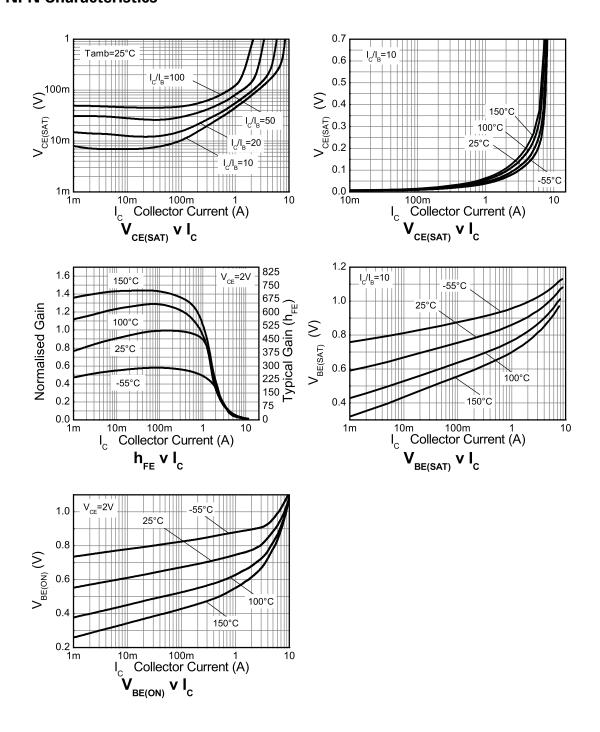
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-base breakdown voltage	BV <sub>CBO</sub>	130(-45)	170(-80)		V	$I_C = (-)100 \mu A$
Collector-emitter breakdown voltage (base open)	BV <sub>CEO</sub>	(-)40	63(-65)		V	I <sub>C</sub> = (-)10mA <sup>(*)</sup> *
Emitter-base breakdown voltage	BV <sub>EBO</sub>	(-)7	(-)8.3		V	I <sub>E</sub> = (-)100μA
Emitter-collector breakdown voltage (reverse blocking)	BV <sub>ECX</sub>	(-)6	(-)7.4		V	$I_E$ = (-)100μA, $R_{BC}$ < 1k $\Omega$ or 0.25V > $V_{BC}$ > -0.25V (0.25V < $V_{BC}$ < -0.25V)
Emitter-collector breakdown voltage (base open)	BV <sub>ECO</sub>	6(-3)	7.4(-8.7)		V	I <sub>E</sub> = (-)100μA
Collector-base cut-off	I <sub>CBO</sub>		<1	(-)50	nA	V <sub>CB</sub> =100(-36)V
current				(-)20	μΑ	$V_{CB} = 100(-36)V$ , $T_{amb} = 100^{\circ}C$
Emitter-base cut-off current	I <sub>EBO</sub>		<1	(-)50	nA	V <sub>EB</sub> = (-)5.6V
Collector-emitter	V <sub>CE(sat)</sub>		50(-70)	60(-90)	mV	$I_C = (-)1A, I_B = (-)100mA *$
saturation voltage			85(-195)	110(-290)	mV	$I_C = (-)1A, I_B = (-)20mA *$
			150	220	mV	$I_C = 2A$ , $I_B = 40mA *$
			(-175)	(-260)	mV	$(I_C = -3A, I_B = -300mA *)$
			135	195	mV	I <sub>C</sub> = 3.5A, I <sub>B</sub> = 350mA *
Base-emitter saturation	V <sub>BE(sat)</sub>		(-935)	(-1000)	mV	$(I_C = -3A, I_B = -300mA *)$
voltage			960	1050	mV	I <sub>C</sub> = 3.5A, I <sub>B</sub> = 350mA *
Base-emitter turn-on	V <sub>BE(on)</sub>		(-855)	(-950)	mV	$(I_C = -3A, V_{CE} = -2V *)$
voltage			860	950	mV	$I_C = 3.5A$ , $V_{CE} = 2V *$
Static forward current	h <sub>FE</sub>	()300	()450	()900		$I_C = (-)10 \text{mA}, V_{CE} = (-)2V *$
transfer ratio		280(200)	400(280)			$I_C = (-)1A, V_{CE} = (-)2V *$
		(20)	(50)			$(I_C = -3A, V_{CE} = -2V *)$
		40	60			$I_C = 3.5A, V_{CE} = 2V *$
Transition frequency	f <sub>T</sub>		190 (270)		MHz	$I_C = (-)50 \text{mA}, V_{CE} = (-)10 \text{V}$ f = 100MHz
Output capacitance	C <sub>OBO</sub>		12(17)	20(25)	pF	V <sub>CB</sub> = (-)10V, f = 1MHz *
Delay time	t <sub>d</sub>		64(57)		ns	$V_{CC} = (-)10V. I_C = (-)1A, I_{B1}$
Rise time	t <sub>r</sub>		108(69)		ns	= I <sub>B2</sub> = (-)10mA.
Storage time	t <sub>s</sub>		428(154)		ns	
Fall time	t <sub>f</sub>		130(60)		ns	

#### NOTES

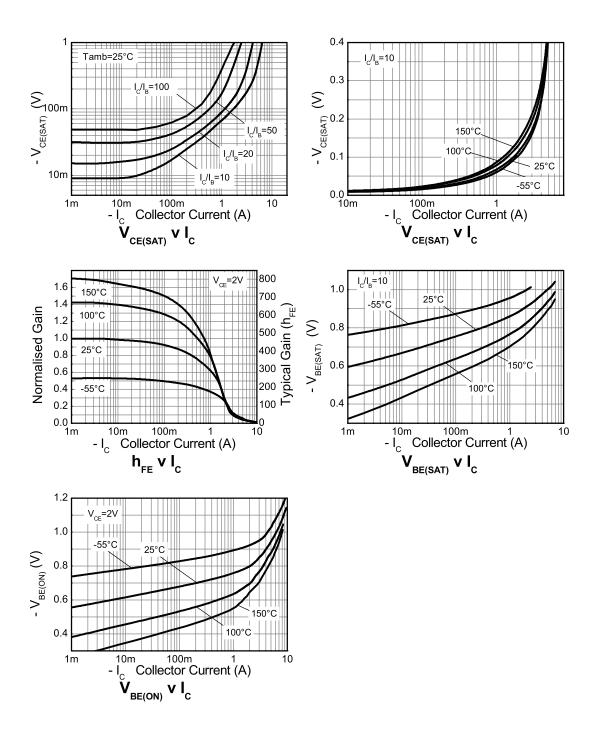
(\*) Measured under pulsed conditions. Pulse width  ${\leq}300\mu s;$  duty cycle  ${\leq}2\%$ 

( ) = PNP

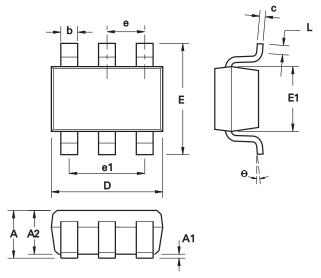
## **NPN Characteristics**



# **PNP Characteristics**



# Package outline - SOT23-6



DIM	Millin	neters	Inches		
	Min.	Max.	Min.	Max.	
Α	0.90	1.45	0.354	0.0570	
A1	0.00	0.15	0.00	0.0059	
A2	0.90	1.30	0.0354	0.0511	
b	0.35	0.50	0.0078	0.0196	
С	0.09	0.26	0.0035	0.0102	
D	2.70	3.10	0.1062	0.1220	
E	2.20	3.20	0.0866	0.1181	
E1	1.30	1.80	0.0511	0.0708	
L	0.10	0.60	0.0039	0.0236	
е	0.95 REF		0.0374 REF		
e1	1.90 REF		0.0748	REF	
L	0°	30°	0°	30°	

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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